

<b>Notice of References Cited</b>	Application/Control No. 10/757,192	Applicant(s)/Patent Under Reexamination DEWITT ET AL.	
	Examiner Raymond Phan	Art Unit 2111	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,628,018	05-1997	Matsuzaki et al.	710/260
*	B	US-5,463,775	10-1995	DeWitt et al.	702/186
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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